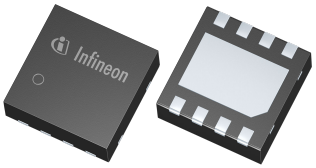
High-speed CAN FD transceiver

Features



- Fully compliant to ISO 11898-2:2024 and SAE J2284-4/-5
- Loop delay symmetry for *controller area network (CAN)* FD data frames up to 5 Mbit/s
- Very low *electromagnetic emission (EME)* allows the use without additional common mode choke
- V_{IO} input for voltage adaption to the microcontroller interface (3.3 V or 5 V)
- Excellent *electrostatic discharge (ESD)* robustness
- TxD timeout function
- Very low CAN bus leakage current in power-down state
- Overtemperature protection
- Protected against automotive transients according to ISO 7637 and SAE J2962-2
- Receive-only mode
- Green Product (RoHS compliant)

RoHS
Green
AEC Qualified
CAN FD

Potential applications

- Engine control units
- Body control modules (BCM)
- Electric power steering
- Transmission control units (TCUs)
- Chassis control modules

Product validation

Qualified for automotive applications. Product validation according to AEC-Q100.

Description

The TLE9350BXLE is a high speed *CAN* transceiver, used in HS CAN systems for automotive applications as well as for industrial applications. It is designed to fulfill the requirements of ISO 11898-2:2024 physical layer specification as well as SAE J1939 and SAE J2284.

The TLE9350BXLE is available in a *Restriction of Hazardous Substances in Electrical and Electronic Equipment (RoHS)* compliant, halogen free PG-TSON-8 package.

As an interface between the physical bus layer and the HS CAN protocol controller, the TLE9350BXLE is designed to protect the microcontroller against interferences generated inside the network. A very high *ESD* robustness and the optimized RF immunity allows the use in automotive applications without additional protection devices, such as suppressor diodes or common mode chokes.

Based on the high symmetry of the CANH and CANL output signals, the TLE9350BXLE provides a very low level of *EME* within a wide frequency range. The TLE9350BXLE fulfills even stringent *electromagnetic compatibility (EMC)* test limits without an additional external circuit, such as a common mode choke.

The optimized transmitter symmetry combined with the optimized delay symmetry of the receiver enables the TLE9350BXLE to support CAN FD data frames. The device supports data transmission rates up to 5 Mbit/s, depending on the size of the network and the inherent parasitic effects.

Fail-safe features, such as overtemperature protection, output current limitation or the TxD timeout feature are designed to protect the TLE9350BXLE and the external circuitry from irreparable damage.

Type	Package	Marking
TLE9350BXLE	PG-TSON-8	9350BX

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1 Block diagram

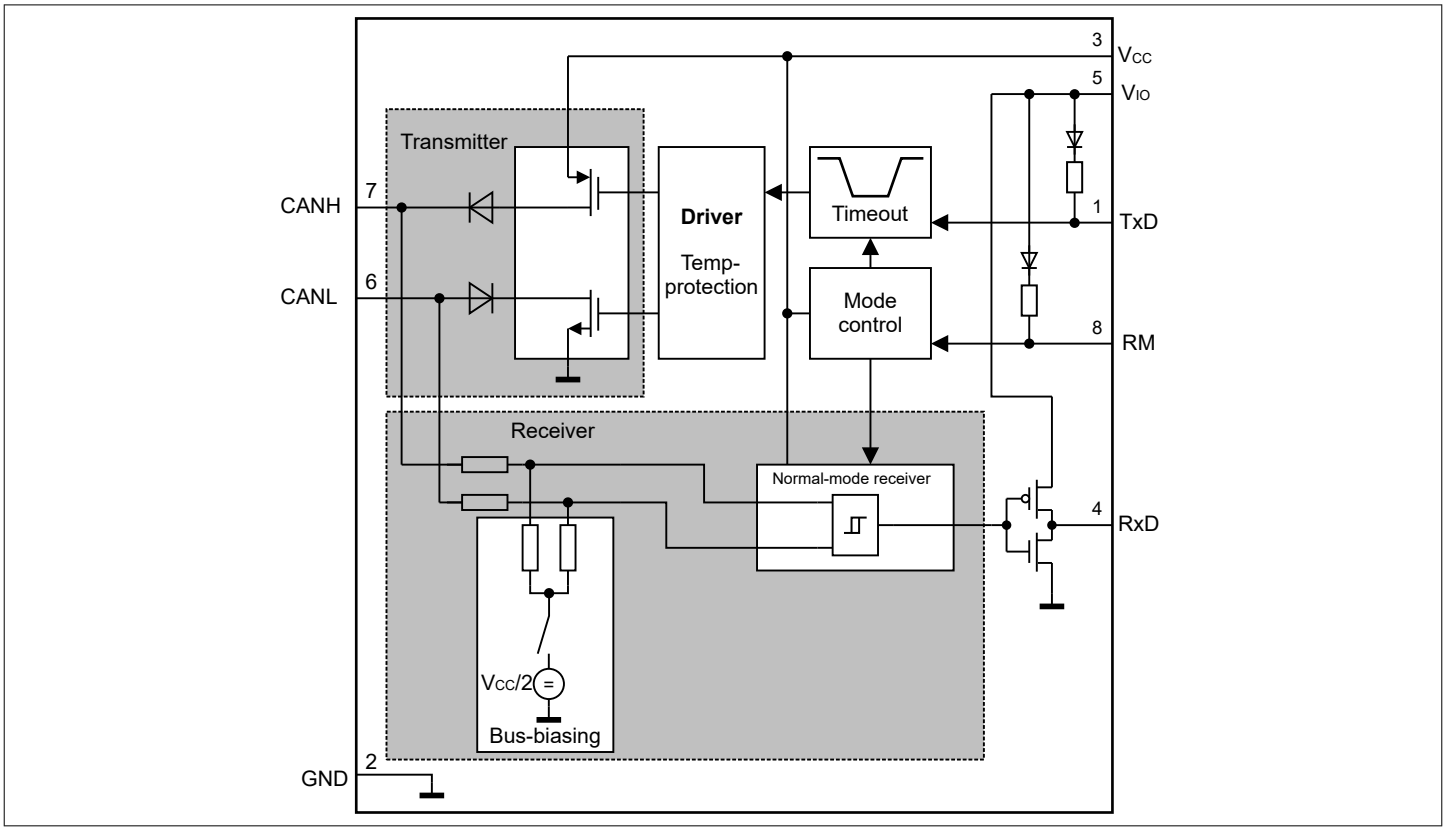

Figure 1 Block diagram

2 Pin configuration

2.1 Pin assignment

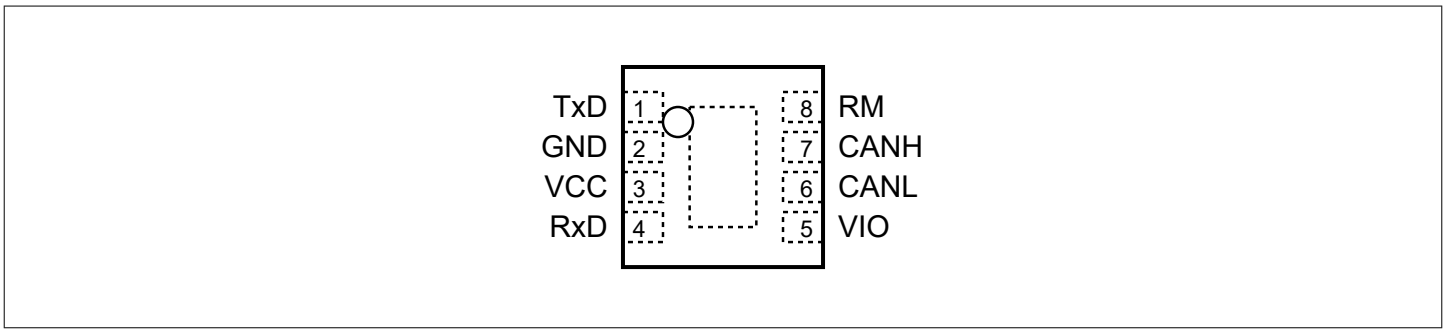

Figure 2 Pin configuration

2.2 Pin definitions and functions

Table 1 Pin definitions and functions

Pin No.	Symbol	Function
1	TxD	**Transmit data input;** Internal pull-up to V_{IO}, "low" for dominant state.
2	GND	**Ground**
3	VCC	**Transmitter supply voltage;** A decoupling capacitor of 1 µF to *ground (GND)* is recommended.
4	RxD	**Receive data output;** "Low" in dominant state.
5	VIO	**Digital supply voltage input;** Adapts the logical input voltage level and output voltage level of the transceiver to the voltage level of the microcontroller supply, A 100 nF decoupling capacitor to GND is recommended.
6	CANL	***CAN* bus low level *input/output (I/O)*;** Bus level on the CANL input/output.
7	CANH	**CAN bus high level I/O;** Bus level on the CANH input/output.
8	RM	**Receive-only input;** Internal pull-up to V_{IO} , "low" for normal-operating mode.
–	Exposed pad	Connect to *printed circuit board (PCB)* heat sink area. Do not connect to other potential than GND.

3 General product characteristics

3.1 Absolute maximum ratings

Table 2 Absolute maximum ratings voltages, currents and temperatures [1)]

All voltages with respect to ground; positive current flowing into pin;
(unless otherwise specified)

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Voltages							
Transmitter supply voltage	V_{CC}	-0.3	–	6.0	V	–	P_7.1.1
Digital supply voltage	V_{IO}	-0.3	–	6.0	V	–	P_7.1.2
CANH and CANL DC voltage versus *GND*	V_{CANH}	-40	–	40	V	–	P_7.1.3
Differential voltage between CANH and CANL	V_{CAN_Diff}	-40	–	40	V	–	P_7.1.4
Voltage at the digital input pins: RM, TxD	V_{MAX_IO}	-0.3	–	6.0	V	–	P_7.1.5
Voltage at the digital output pin: RxD	V_{MAX_RxD}	-0.3	–	V_{IO} +0.3	V	–	P_7.1.9
Currents							
RxD output current	I_{RxD}	-5	–	5	mA	–	P_7.1.6
Temperatures							
Junction temperature	T_j	-40	–	150	°C	–	P_7.1.7
Storage temperature	T_S	-55	–	150	°C	–	P_7.1.8
ESD robustness							
ESD robustness at CANH, CANL versus GND	$V_{ESD\_HBM\_CAN}$	-10	–	10	kV	2) HBM;	P_7.1.10
ESD robustnessat all other pins	$V_{ESD\_HBM\_ALL}$	-2	–	2	kV	2) HBM;	P_7.1.11
ESD robustness at corner pins	$V_{ESD\_CDM\_CP}$	-750	–	750	V	3) CDM	P_7.1.14
ESD immunity at any other pins	V_{ESD_CDM}	-500	–	500	V	3) CDM	P_7.1.12

1) Not subject to production test, specified by design.
2) Human body model (*human body model (HBM)*) robustness according to AE - Q100-002.
3) Charged device model (*charged device model (CDM)*) robustness according to AEC - Q100-011 Rev-D; voltage level refers to test condition (TC) mentioned in the standard.

***Note**: Latchup robustness: class II according to AEC - Q100-04.*

3.2 Functional range

Table 3 Functional range

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Supply voltages							
Transmitter supply voltage	V_{CC}	4.5	–	5.5	V	–	P_7.2.1
Digital supply voltage	V_{IO}	3.0	–	5.5	V	–	P_7.2.2
Thermal parameters							
Junction temperature	T_j	-40	–	150	°C	1)	P_7.2.3

1) Not subject to production test, specified by design.

***Note**: Within the functional range the integrated circuit (IC) operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.*

3.3 Thermal resistance

***Note**: This thermal data was generated in accordance with JEDEC JESD51 standards. For more information, please visit www.jedec.org.*

Table 4 Thermal resistance 1)

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Thermal resistance							
Junction to ambient PG-TSON-8	R_{thJA_TSON8}	–	65	–	K/W	2)	P_7.3.2
Thermal shutdown (junction temperature)							
Thermal shutdown temperature, rising	T_{JSD}	170	180	190	°C	Temperature falling: minimum 150°C	P_7.3.3
Thermal shutdown hysteresis	ΔT	5	10	20	K	–	P_7.3.4

1) Not subject to production test, specified by design
2) Specified R_{thJA} value is according to JEDEC JESD51-2,-7 at natural convection on FR4 2s2p board. The product was simulated on a 76.2 × 114.3 × 1.5 mm^3 board with two inner copper layers (2 × 70µm Cu, 2 × 35µm Cu).

4 High speed CAN functional description

HS *CAN* is a serial bus system that connects microcontrollers, sensors and actuators for real-time control applications. ISO 11898 describes the use of the CAN within road vehicles. According to the 7-layer OSI reference model the physical layer of a HS CAN bus system specifies the data transmission from one CAN node to all other CAN nodes available within the network. The physical layer specification of a CAN bus system includes all electrical specifications of a CAN. The CAN transceiver is part of the physical layer specification.

4.1 High speed CAN physical layer

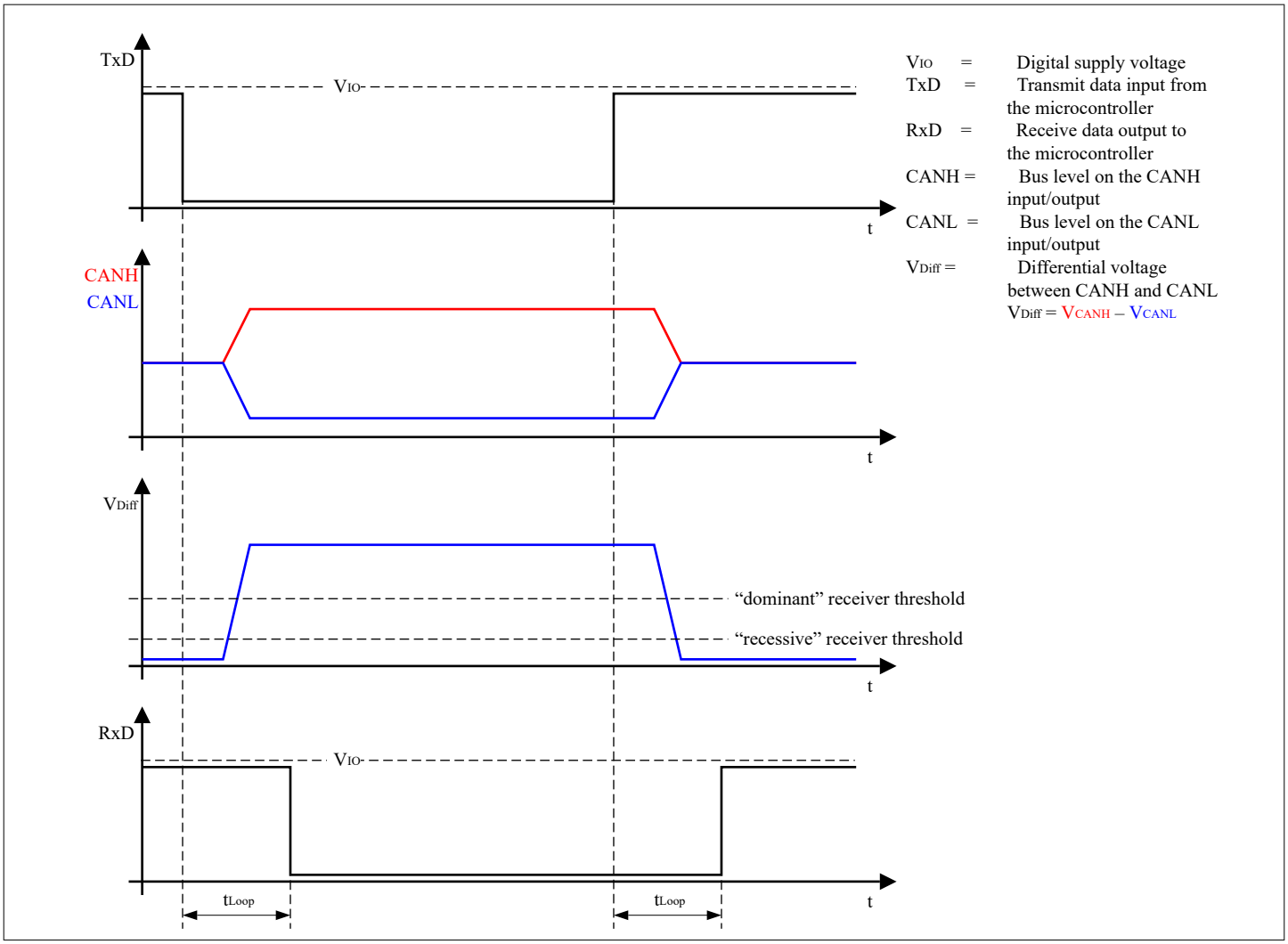

Figure 3 High speed CAN bus signals and logic signals

The device operates as an interface between the *CAN* controller and the physical bus medium. A HS CAN is a two wire differential network which allows data transmission rates up to 5 Mbit/s. The characteristics for a HS CAN are the two signal states on the CAN bus: dominant and recessive (see Figure 3).

The CANH and CANL pins are the interface to the CAN bus and both pins operate as an input and output simultaneously. The RxD and TxD pins are the interface to the microcontroller. The pin TxD is the serial data input from the CAN controller, the RxD pin is the serial data output to the CAN controller. As shown in Figure 1 , the device includes a receiver and a transmitter unit, allowing the transceiver to send data to the bus medium and monitor the data from the bus medium at the same time. The device converts the serial data stream which is available on the transmit data input TxD, into a differential output signal on the CAN bus, provided by the CANH and CANL pins. The receiver stage of the device monitors the data on the CAN bus and converts them to a serial, single-ended signal on the RxD output pin. A "low" signal on the TxD pin creates a dominant signal on the CAN bus, followed by a logical "low" signal on the RxD pin (see Figure 3). The feature of broadcasting data to the CAN bus and listening to the data traffic on the CAN bus simultaneously is essential to support the bit-to-bit arbitration within CAN.

ISO 11898-2:2024 specifies the voltage levels for HS CAN transceivers. Whether a data bit is dominant or recessive depends on the voltage difference between the CANH and CANL pins ($V_{Diff} = V_{CANH} - V_{CANL}$).

To transmit a dominant signal to the CAN bus the amplitude of the differential signal V_{Diff} is higher than or equal to 1.5 V. To receive a recessive signal from the CAN bus the amplitude of the differential V_{Diff} is lower than or equal to 0.5 V.

In partially-supplied high speed CAN network, the bus nodes of one common network have different power supply conditions. Some nodes are connected to the power supply, while other nodes are disconnected from the power supply and in power-down state. Regardless of whether the CAN bus subscriber is supplied or not, each subscriber connected to the common bus media must not interfere with the communication. The device is designed to support partially-supplied networks. In power-down state, the receiver input resistors are switched off and the transceiver input has a high resistance.

The voltage level on the digital input TxD and the digital output RxD is determined by the power supply level at the V_{IO} pin. Depending on the voltage level at the V_{IO} pin, the signal levels on the logic pins (STB, TxD and RxD) are compatible with microcontrollers having a 5 V or 3.3 V *I/O* supply. Usually the digital power supply V_{IO} of the transceiver is connected to the I/O power supply of the microcontroller (see Figure 12).

5 Modes of operation

The device supports the following modes of operation):

- Normal-operating mode
- Receive-only mode

The mode selection input pin RM triggers mode changes. Undervoltage on V_{CC} disables the transmitter output stage. An undervoltage event on the digital supply V_{IO} powers down the device.

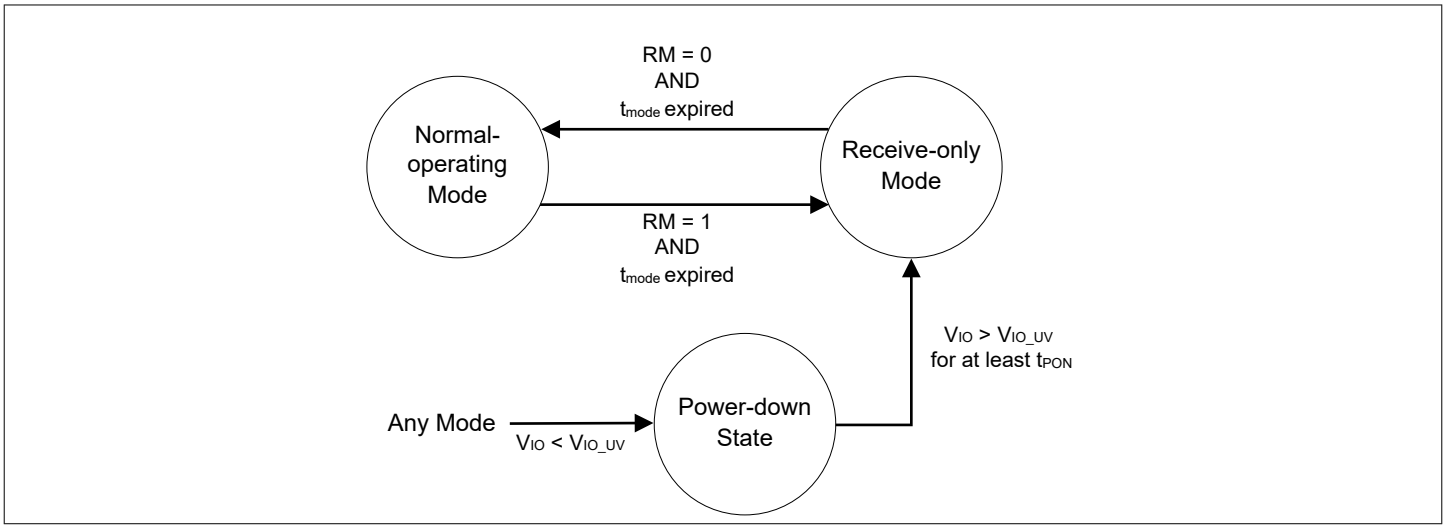

Figure 4 Mode state diagram

5.1 Normal-operating mode

In normal-operating mode all functions of the device are available and the device is fully functional. Data can be received from the HS *CAN* bus as well as transmitted to the HS CAN bus.

- The transmitter is enabled and drives the serial data stream on the TxD input pin to the bus pins CANH and CANL.
- The receiver is enabled and converts the signal from the bus to a serial data stream on the RxD output pin.
- The bus biasing is connected to $V_{CC}/2$ for $V_{CC} > V_{CC\_UV}$
- The TxD timeout function is enabled (see Chapter 6.4).
- The overtemperature protection is enabled (see Chapter 6.6).
- The undervoltage detection on $V_{CC}$and V_{IO} are enabled (see Chapter 6.3 and Chapter 5.3).

The device enters normal-operating mode by setting the mode selection pin RM to "low", see Figure 4 . Normal-operating mode can be entered if the device supply V_{CC} is higher than V_{CC_UV} . The device enters normal-operating mode after t_{mode} expires.

***Note**:* *If the device recognizes a recessive signal on the TxD input pin during a mode change from any mode to normal-operating mode, then it enables the transmit path after the mode change.*

If the device recognizes a dominant signal on the TxD input pin during a mode change to normal-operating mode, then it keeps the transmit path disabled and it blocks the dominant signal in order to not disturb the bus communication . As soon as the device recognizes a recessive signal on the TxD input pin, it enables the transmit path again.

5.2 Receive-only mode

In receive-only mode the transmitter is disabled and the receiver is enabled. The TLE9350BXLE can receive data from the HS *CAN* bus, but cannot transmit data to the HS CAN bus.

- The transmitter is disabled and the data available on the TxD input is blocked.

- The receiver is enabled and converts the signal from the bus to a serial data stream on the RxD output pin.
- The bus biasing is connected to $V_{CC}/2$ for $V_{CC} > V_{CC\_UV}$.
- The TxD timeout function is disabled.
- The undervoltage detection on $V_{CC}$and V_{IO} are enabled (see Chapter 6.3 and Chapter 5.3).

If the mode selection pin RM is set to "high" , then the TLE9350BXLE enters receive-only. V_{IO} must be higher than V_{IO_UV} as a prerequisite to enter receive-only mode. The device enters receive-only mode after t_{mode} expires.

5.3 Power-down state

If the supply voltage $V_{IO} < V_{IO\_UV}$, then the device powers down independently of Independent of the transmitter supply V_{CC} and RM input pin (see Figure 5). In power-down state all functions of the device are disabled and the device is switched off. The input resistors of the receiver are disconnected. The CANH and CANL bus interface of the device is floating and acts as a high impedance input with a very low leakage current. The high impedance input does not influence the recessive level of the *CAN* and allows an optimized *EME* performance of the entire network. In power-down state the transceiver is an invisible node to the bus. t_{pon} must expire as a prerequisite for the device to exit power-down state.

- The transmitter and receiver are disabled.
- The bus biasing is connected to high impedance.
- The TxD timeout function is disabled.
- The overtemperature protection is disabled.
- The undervoltage detection on V_{CC} is disabled .
- The undervoltage detection on V_{IO} is enabled.

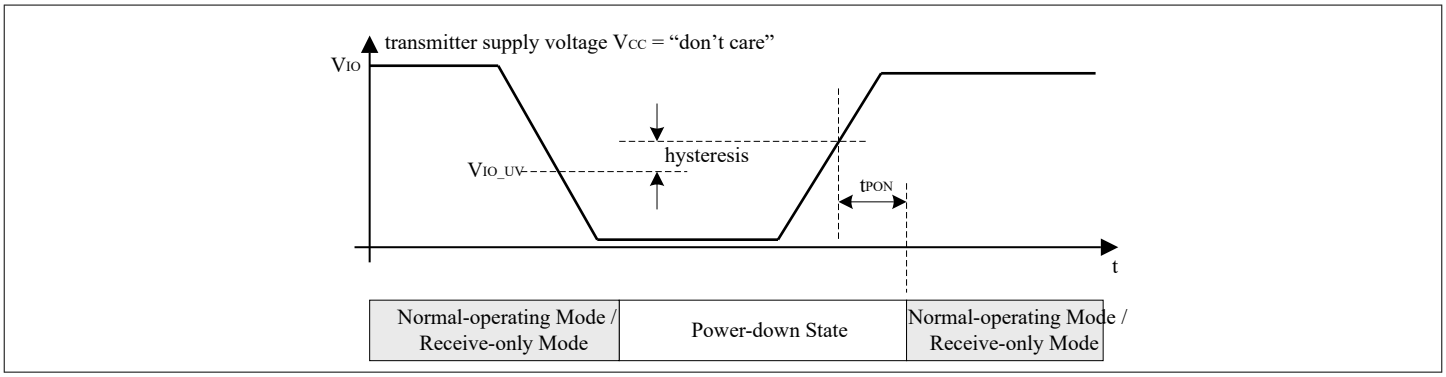

Figure 5 Power-down and power-up behavior and V_{IO}

6 Fail safe functions

6.1 Short circuit protection

The CANH and CANL bus outputs are short circuit proof to *GND* and short circuit proof to a supply voltage. The current limiting circuit is designed to protect the transceiver from damage. If the device heats up due to a continuous short on the CANH or CANL, then the internal overtemperature protection switches off the bus transmitter.

6.2 Unconnected logic pins

All logic input pins have an internal pull-up resistor to V_{IO} . If the V_{IO} and V_{CC} supply is active and the logical pins are open, the device enters the normal-operating mode by default.

6.3 V_{CC} undervoltage

If the transmitter supply is in undervoltage condition $V_{CC} < V_{CC\_UV}$, then the device might not be able to provide the correct bus levels on the CANH and CANL output pins. During this time the transmitter is blocked in normal-operating mode, to avoid any interference with the network.

During undervoltage condition $V_{CC} < V_{CC\_UV}$, the bus biasing is switched to ground in normal-operating mode and receive-only mode.

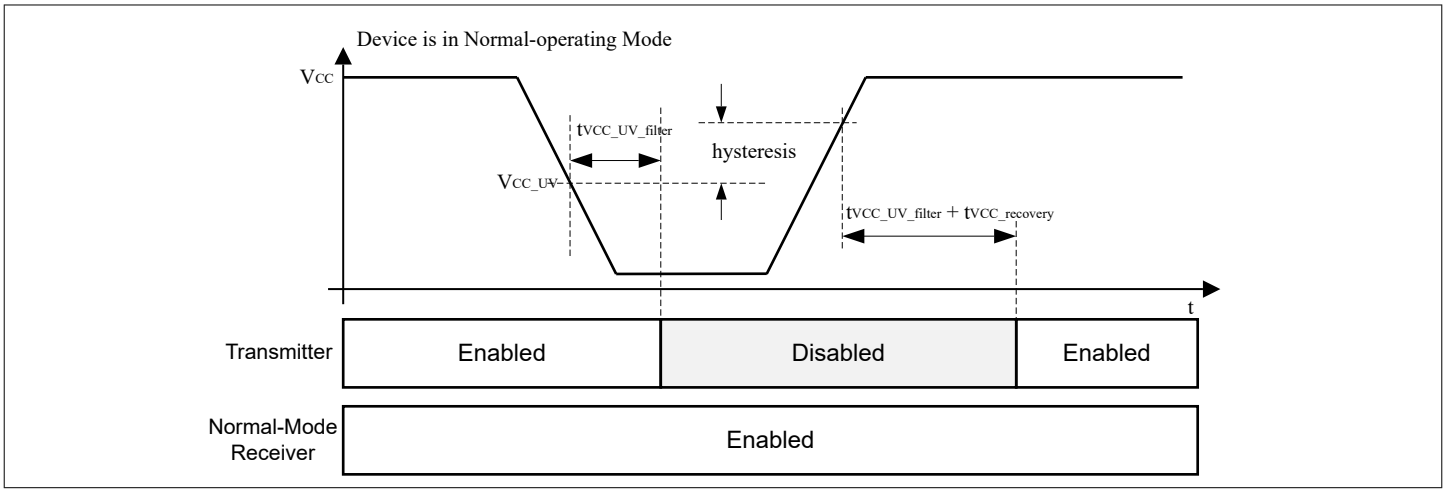

Figure 6 Undervoltage on the transmitter supply V_{CC}

6.4 TxD timeout feature

The TxD timeout feature protects the *CAN* bus against permanent blocking in case the logical signal on the TxD pin is continuously "low". A continuous "low" signal on the TxD pin might have its root cause in a locked-up microcontroller or in a short circuit on the printed circuit board, for example.

In normal-operating mode, a "low" signal on the TxD pin for the time $t > t_{TxD}$ enables the TxD timeout feature and the device disables the transmitter, see Figure 7. The receiver is still active and the device continues to monitor data on the bus via the RxD output pin.

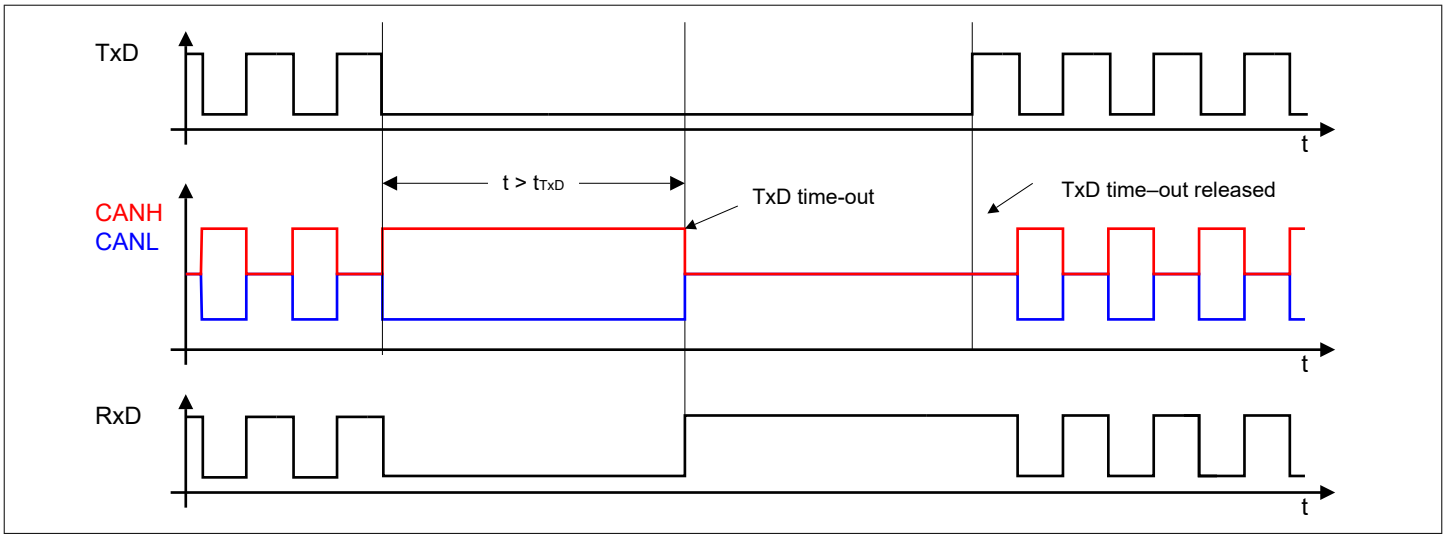

Figure 7 TxD timeout function

Figure 7 shows how the transmitter is deactivated and activated again. A permanent "low" signal on the TxD input pin activates the TxD timeout and deactivates the transmitter. To release the transmitter after a TxD timeout event, the device requires a signal change on the TxD input pin from "low" to "high".

6.5 Delay time for mode change

The device changes the mode of operation within the time window t_{Mode}.

6.6 Overtemperature protection

The device has an integrated overtemperature detection, which is designed to protect the device against thermal overstress of the transmitter. The overtemperature protection is only active in normal-operating mode. In case of an overtemperature condition, the temperature sensor disables the transmitter while the transceiver remains in normal-operating mode. After the device cools down it enables the transmitter again (see Figure 8). A hysteresis is implemented within the temperature sensor.

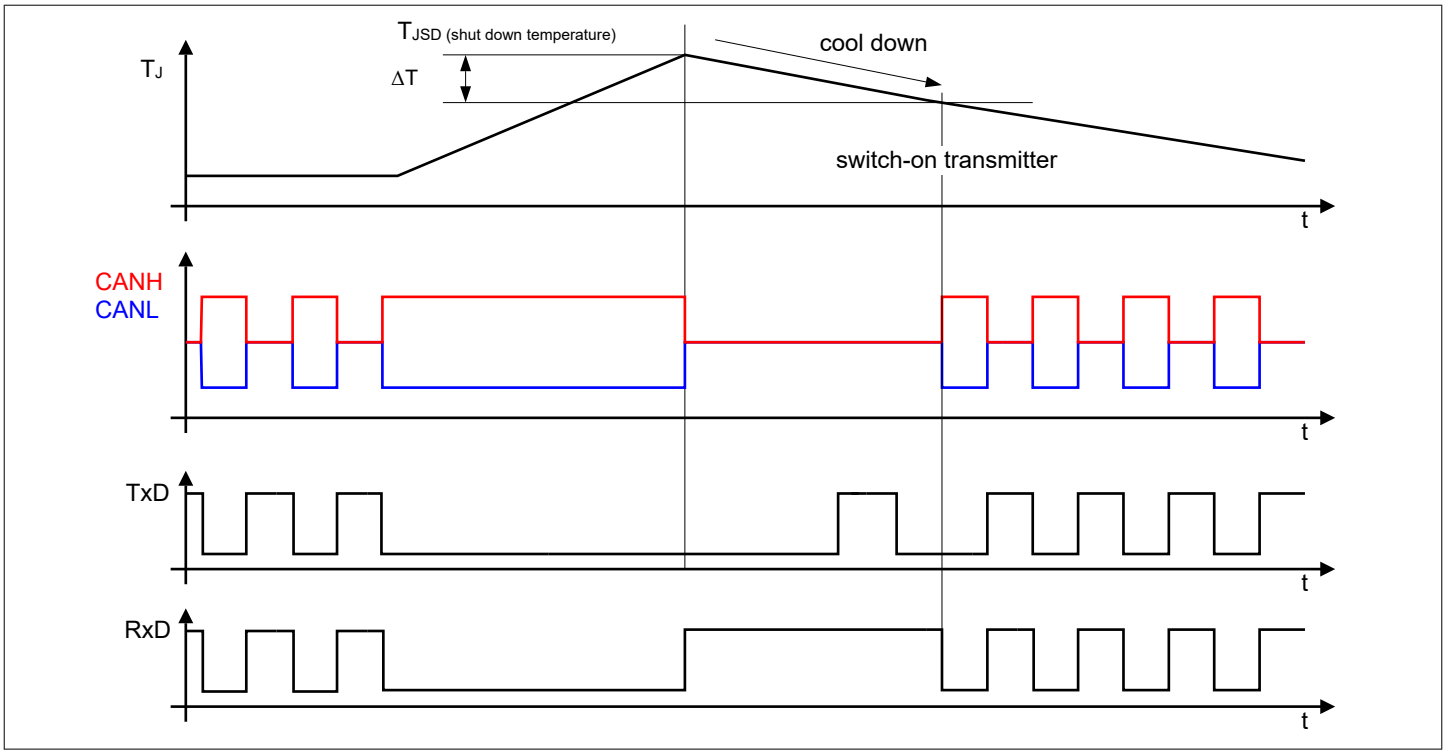

Figure 8 Overtemperature protection

7 Electrical characteristics

7.1 Power supply interface

7.1.1 Electrical characteristics current consumption

Table 5 Electrical characteristics current consumption

4.5 V < V_{CC} < 5.5 V; 3.0 V < V_{IO} < 5.5 V; R_L = 60 Ω; -40°C < T_j < 150°C; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Current consumption at V_{CC} normal-operating mode, recessive state	I_{CC_R}	–	1.4	4	mA	$V_{TxD} = V_{IO}$; V_{RM} = 0 V; $V_{CANH} = V_{CANL} = V_{CC}/2$	P_8.1.1
Current consumption at V_{CC} normal-operating mode, dominant state	I_{CC_D}	–	34	48	mA	$V_{TxD} = V_{RM}$ = 0 V;	P_8.1.2
Current consumption at V_{IO} normal-operating mode	I_{IO}	–	0.9	1.5	mA	V_{RM} = 0 V; V_{Diff} = 0 V; recessive	P_8.1.3
Current consumption at V_{CC} receive-only mode	$I_{CC\ (ROM)}$	–	0.2	1	mA	$V_{RM} = V_{IO}$	P_8.1.9
Current consumption at V_{IO} receive-only mode	$I_{IO\ (ROM)}$	–	0.8	1.5	mA	$V_{RM} = V_{IO}$	P_8.1.10

7.1.2 Electrical characteristics undervoltage detection

Table 6 Electrical characteristics undervoltage detection

4.5 V < V_{CC} < 5.5 V; 3.0 V < V_{IO} < 5.5 V; R_L = 60 Ω; -40°C < T_j < 150°C; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
V_{CC} undervoltage threshold	V_{CC_UV}	3.8	4.2	4.5	V	See Figure 6	P_8.1.11
V_{CC} undervoltage filter time	$t_{VCC\_UV\_filter}$	4	6	10	µs	1) See Figure 6	P_8.1.13
V_{CC} undervoltage recovery time	$t_{VCC\_recovery}$	–	7	70	µs	1) See Figure 6	P_8.1.14
V_{IO} undervoltage threshold	V_{IO_UV}	2.0	2.6	3.0	V	–	P_8.1.15
V_{IO} delay time power-up	t_{PON}	–	40	280	µs	1) See Figure 5	P_8.1.19

1) Not subject to production test, specified by design.

7.2 Electrical characteristics CAN controller interface

Table 7 Electrical characteristics CAN controller interface

4.5 V < V_{CC} < 5.5 V; 3.0 V < V_{IO} < 5.5 V; R_L = 60 Ω; -40°C < T_j < 150°C; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Receiver output RxD							
"High" level output current	I_{RxD_H}	–	-2.5	-1	mA	$V_{RxD} = V_{IO}$ – 0.4 V; V_{Diff} < 0.5 V	P_8.2.1
"Low" level output current	I_{RxD_L}	1	2.5	–	mA	V_{RxD} = 0.4 V; V_{Diff} > 0.9 V	P_8.2.2
Transmission input TxD							
"High" level input voltage	V_{TxD_H}	0.7 × V_{IO}	–	6.0	V	Recessive state	P_8.2.3
"Low" level input voltage	V_{TxD_L}	-0.3	–	0.3 × V_{IO}	V	Dominant state	P_8.2.4
Internal pull-up resistor TxD	R_{TxD}	35	55	70	kΩ	–	P_8.2.7
Input capacitance	C_{TxD}	–	–	10	pF	1)	P_8.2.8
TxD permanent dominant timeout	t_{TxD}	1	2.3	4	ms	Normal-operating mode	P_8.2.9
Receive-only input RM							
"High" level input voltage	V_{RM_H}	0.7 × V_{IO}	–	6.0	V	Receive-only mode	P_8.2.13
"Low" level input voltage	V_{RM_L}	-0.3	–	0.3 × V_{IO}	V	Normal-operating mode	P_8.2.14
Internal pull-up resistor RM	R_{RM}	35	55	70	kΩ	–	P_8.2.17
Input capacitance	$C_{(RM)}$	–	–	10	pF	1)	P_8.2.20

1) Not subject to production test, specified by design.

7.3 Electrical characteristics receiver

Table 8 Electrical characteristics receiver

4.5 V < V_{CC} < 5.5 V; 3.0 V < V_{IO} < 5.5 V; R_L = 60 Ω; -40°C < T_j < 150°C; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Differential range dominant normal-operating mode	$V_{Diff\_D\_Range}$	0.9	–	8.0	V	1) -12 V ≤ V_{CMR} ≤ 12 V	P_8.3.3
Differential range recessive normal-operating mode	$V_{Diff\_R\_Range}$	-3.0	–	0.5	V	1) -12V ≤ V_{CMR} ≤ 12 V	P_8.3.5
Common mode voltage	V_{CMR}	-12	–	12	V	–	P_8.3.11
Single ended internal resistance	R_{CAN_H}, R_{CAN_L}	6	40	50	kΩ	1) Recessive state; -2 V ≤ V_{CANH} ≤ 7 V; -2 V ≤ V_{CANL} ≤ 7 V	P_8.3.12
Differential internal resistance	R_{Diff}	12	80	100	kΩ	1) Recessive state; -2 V ≤ V_{CANH} ≤ 7 V; -2 V ≤ V_{CANL} ≤ 7 V	P_8.3.14
Input resistance deviation between CANH and CANL	ΔR_i	-2	–	2	%	1) Recessive state; V_{CANH} = V_{CANL} = 5 V	P_8.3.16
Input capacitance CANH, CANL versus *GND*	C_{In}	–	–	40	pF	1) 2) Recessive state; normal-operating mode	P_8.3.17
Differential input capacitance	C_{InDiff}	–	4	20	pF	1) 2) Recessive state; normal-operating mode	P_8.3.18

1) Not subject to production test, specified by design.
2) S2P-method; f = 10 MHz.

7.4 Electrical characteristics transmitter

Table 9 Electrical characteristics transmitter

4.5 V < V_{CC} < 5.5 V; 3.0 V < V_{IO} < 5.5 V; R_L = 60 Ω; -40°C < T_j < 150°C; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
CANL, CANH recessive output voltage normal-operating mode	$V_{CANL,H}$	2.0	2.5	3.0	V	V_{TxD} = V_{IO}; no load	P_8.4.1
CANH, CANL recessive output voltage difference normal-operating mode	$V_{Diff\_R\_NM}$ = V_{CANH} -V_{CANL}	-50	-10	50	mV	V_{TxD} = V_{IO}; no load	P_8.4.2
CANL dominant output voltage normal-operating mode	V_{CANL}	0.5	1.5	2.25	V	V_{TxD} = 0 V; 50 Ω < R_L < 65 Ω	P_8.4.3
CANH dominant output voltage normal-operating mode	V_{CANH}	2.75	3.4	4.5	V	V_{TxD} = 0 V; 50 Ω < R_L < 65 Ω	P_8.4.4
Differential voltage dominant normal-operating mode V_{Diff} = V_{CANH} - V_{CANL}	$V_{Diff\_D\_NM}$	1.5	1.9	2.5	V	V_{TxD} = 0 V; 50 Ω < R_L < 65 Ω; 4.75 V < V_{CC} < 5.25 V	P_8.4.5
Differential voltage dominant extended bus load normal-operating mode	$V_{Diff\_EXT\_BL}$	1.4	1.9	3.3	V	V_{TxD} = 0 V; 45 Ω < R_L < 70 Ω; 4.75 V < V_{CC} < 5.25 V	P_8.4.6
Differential voltage dominant high extended bus load normal-operating mode	$V_{Diff\_HEXT\_BL}$	1.5	3.5	5.0	V	[1] V_{TxD} = 0 V; R_L = 2240 Ω; static behavior; 4.75 V < V_{CC} < 5.25 V	P_8.4.7
Driver symmetry (V_{SYM} = V_{CANH} + V_{CANL})	V_{SYM}	0.9 × V_{CC}	1.0 × V_{CC}	1.1 × V_{CC}	V	[1] [2] C_1 = 4.7 nF	P_8.4.10
CANL short circuit current	I_{CANLsc}	-115	90	115	mA	[1] -3 V < $V_{CANLshort}$ < 18 V; t < t_{TxD}; V_{TxD} = 0 V	P_8.4.11
CANH short circuit current	I_{CANHsc}	-115	-90	115	mA	[1] -3 < $V_{CANHshort}$ < 18 V t < t_{TxD}; V_{TxD} = 0 V	P_8.4.13
Leakage current, CANH	$I_{CANH,lk}$	-5	1	5	µA	V_{CC} = V_{IO} = 0 V; 0 V < V_{CANH} ≤ 5 V; V_{CANH} = V_{CANL}	P_8.4.19

(table continues...)

Table 9 (continued) Electrical characteristics transmitter

4.5 V < V_{CC} < 5.5 V; 3.0 V < V_{IO} < 5.5 V; R_L = 60 Ω; -40°C < T_j < 150°C; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Leakage current, CANL	$I_{CANL,lk}$	-5	1	5	µA	V_{CC} = V_{IO} = 0 V; 0 V < V_{CANL} ≤ 5 V; V_{CANH} = V_{CANL}	P_8.4.20
CANH, CANL output voltage difference slope, recessive to dominant	$V_{diff\_slope\_rd}$	–	42	70	V/µs	1) 30% to 70% of measured differential bus voltage; C_2 = 100 pF; R_L = 60 Ω; 4.75 V < V_{CC} < 5.25 V	P_8.4.21
CANH, CANL output voltage difference slope, dominant to recessive	$V_{diff\_slope\_dr}$	-70	-42	–	V/µs	1) 70% to 30% of measured differential bus voltage; C_2 = 100 pF; R_L = 60 Ω; 4.75 V < V_{CC} < 5.25 V	P_8.4.22

1) Not subject to production test, specified by design.
2) V_{SYM} is observed during dominant and recessive state and also during the transition from dominant to recessive state and vice versa, while TxD is stimulated by a square wave signal with a frequency of 1 MHz .

7.5 Electrical characteristics dynamic transceiver parameters

Table 10 Electrical characteristics dynamic transceiver parameters

4.5 V < V_{CC} < 5.5 V; 3.0 V < V_{IO} < 5.5 V; R_L = 60 Ω; -40°C < T_j < 150°C; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Propagation delay TxD-to-RxD	t_{Loop}	80	150	235	ns	C_1 = 0 pF; C_2 = 100 pF; C_2 = 150 pF; (see Figure 10)	P_8.5.1
Propagation delay increased load TxD-to-RxD	t_{Loop_150}	80	180	330	ns	C_1 = 0 pF; C_2 = 100 pF; C_{RxD} = 15 pF; R_L = 150 Ω	P_8.5.2
Propagation delay TxD to bus "low" to dominant	$t_{d(L)\_T}$	30	70	140	ns	C_1 = 0 pF; C_2 = 100 pF; C_{RxD} = 15 pF; (see Figure 10)	P_8.5.3
Propagation delay TxD to bus "high" to recessive	$t_{d(H)\_T}$	30	90	140	ns	C_1 = 0 pF; C_2 = 100 pF; C_{RxD} = 15 pF; (see Figure 10)	P_8.5.4
Propagation delay bus to RxD dominant to "low"	$t_{d(L)\_R}$	30	90	140	ns	C_{RxD} = 15 pF; Independent of t_{Bit}; (see Figure 10)	P_8.5.5
Propagation delay bus to RxD recessive to "high"	$t_{d(H)\_R}$	30	100	140	ns	C_{RxD} = 15 pF; Independent of t_{Bit}; (see Figure 10)	P_8.5.6
Delay times							
Delay time for mode change	t_{Mode}	–	12	20	µs	1)	P_8.5.7
***CAN* FD characteristics**							
Received recessive bit width variation up to 2 Mbit/s	$t_{Bit(RxD)\_2M}$	-100	–	50	ns	C_2 = 100 pF; C_{RxD} = 15 pF; t_{Bit} = 500 ns; see Figure 11	P_8.5.13

(table continues...)

Table 10 (continued) Electrical characteristics dynamic transceiver parameters

4.5 V < V_{CC} < 5.5 V; 3.0 V < V_{IO} < 5.5 V; R_L = 60 Ω; -40°C < T_j < 150°C; all voltages with respect to ground; positive current flowing into pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Received recessive bit width variation up to 5 Mbit/s	$t_{Bit(RxD)\_5M}$	-80	–	20	ns	C_2 = 100 pF; C_{RxD} = 15 pF; t_{Bit} = 200 ns; see Figure 11	P_8.5.14
Transmitted recessive bit width variation up to 2 Mbit/s	$t_{Bit(Bus)\_2M}$	-45	–	10	ns	C_2 = 100 pF; C_{RxD} = 15 pF; t_{Bit} = 500 ns; see Figure 11	P_8.5.15
Transmitted recessive bit width variation up to 5 Mbit/s	$t_{Bit(Bus)\_5M}$	-45	–	10	ns	C_2 = 100 pF; C_{RxD} = 15 pF; t_{Bit} = 200 ns; see Figure 11	P_8.5.16
Receiver timing symmetry up to 2 Mbit/s $\Delta t_{Rec\_2M} = t_{Bit(RxD)\_2M} - t_{Bit(Bus)\_2M}$	Δt_{Rec_2M}	-45	-23	15	ns	C_2 = 100 pF; C_{RxD} = 15 pF; t_{Bit} = 500 ns; 4.75 V < V_{CC}< 5.25 V; see Figure 11	P_8.5.17
Receiver timing symmetry up to 5 Mbit/s	Δt_{Rec_5M}	-45	-23	15	ns	C_2 = 100 pF; C_{RxD} = 15 pF; t_{Bit} = 200 ns; 4.75 V < V_{CC}< 5.25 V; see Figure 11	P_8.5.18

1) Not subject to production test, specified by design.

7.6 Diagrams

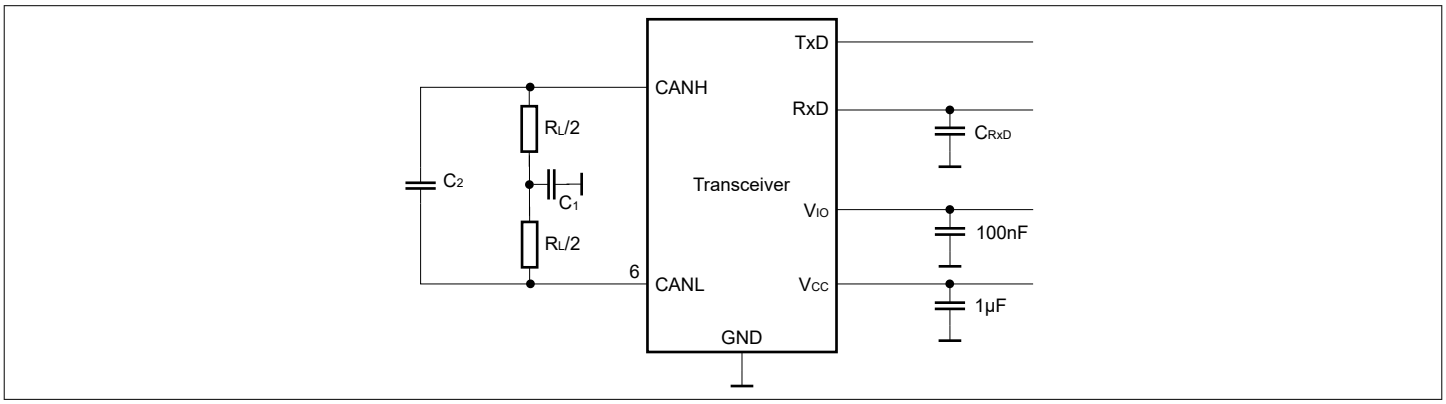

Figure 9 Test circuit

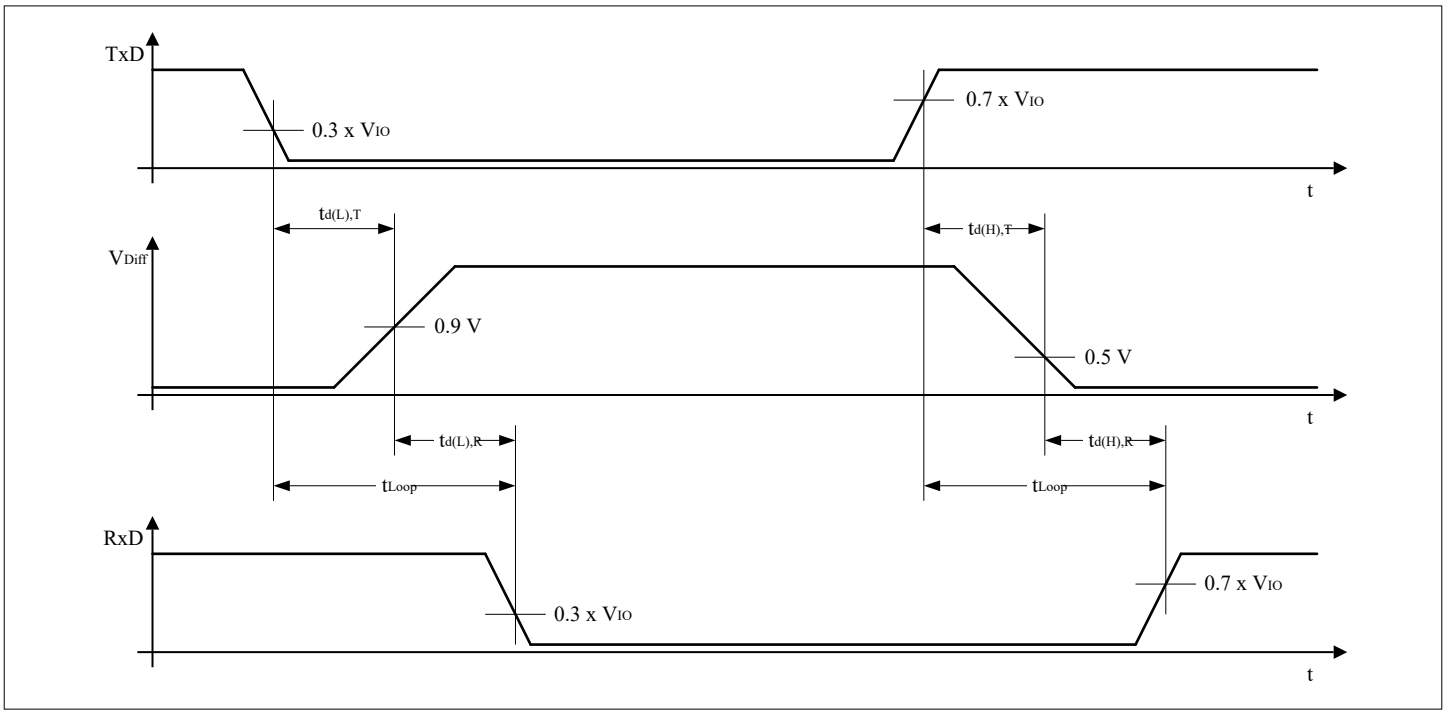

Figure 10 Timing diagrams for dynamic characteristics

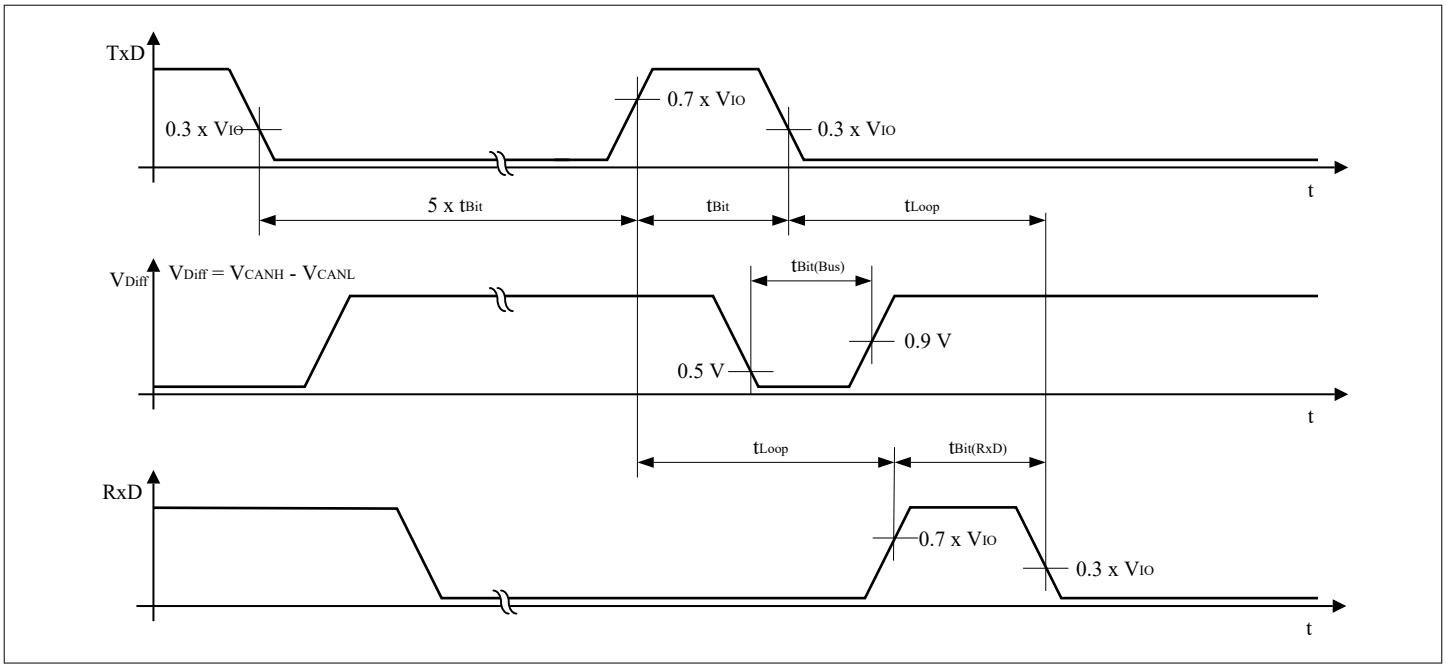

Figure 11 Recessive bit time for five dominant bits followed by one recessive bit

8 Application information

8.1 ESD robustness according to IEC 61000-4-2

Tests for *ESD* robustness according to IEC 61000-4-2 Gun test (150 pF, 330 Ω) have been performed. The results and test conditions are available in a separate test report.

Table 11 ESD robustness according to IEC 61000-4-2

Performed test	Result	Unit	Remarks
Electrostatic discharge voltage at pin CANH and CANL versus *GND*	≥ +8	kV	1) Positive pulse
Electrostatic discharge voltage at pin CANH and CANL versus GND	≤ -8	kV	1) Negative pulse

1) Not subject to production test. ESD robustness "ESD GUN" according to GIFT/ICT paper: "*EMC* Evaluation of *CAN* Transceivers, version IEC TS62228", section 4.3. (DIN EN61000-4-2)
Tested by external test facility (IBEE Zwickau).

8.2 Application example

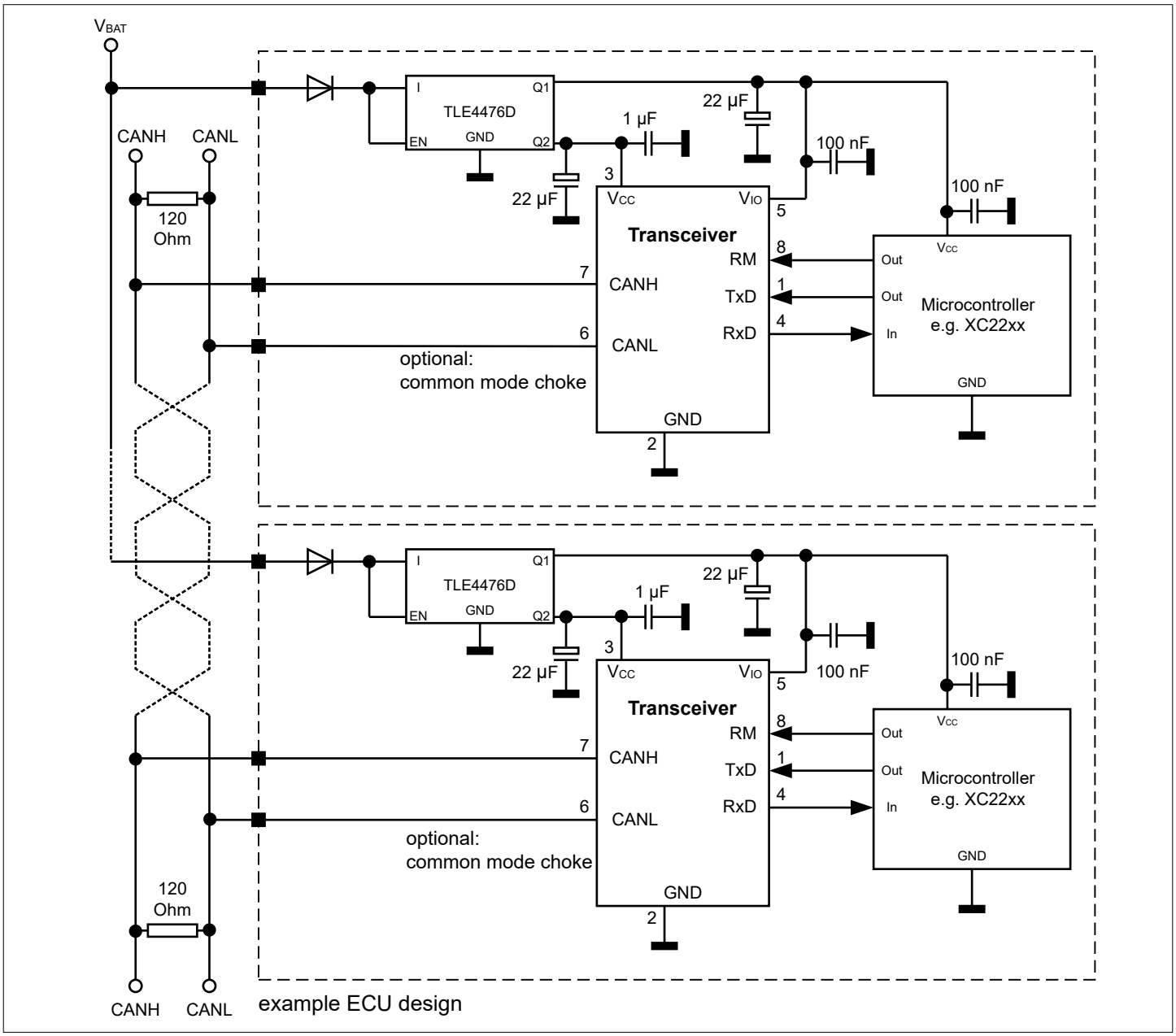

Figure 12 Application circuit

8.3 Voltage adaption to the microcontroller supply

To adapt the digital input and output levels of the device to the *I/O* levels of the microcontroller, connect the power supply pin V_{IO} to the microcontroller voltage supply, see Figure 12 .

***Note**: If no dedicated digital supply voltage V_{IO} is required in the application, then connect the digital supply voltage V_{IO} to the transmitter supply V_{CC}.*

8.4 Further application information

For further information you may visit: https://www.infineon.com/automotive-transceiver

9 Package information

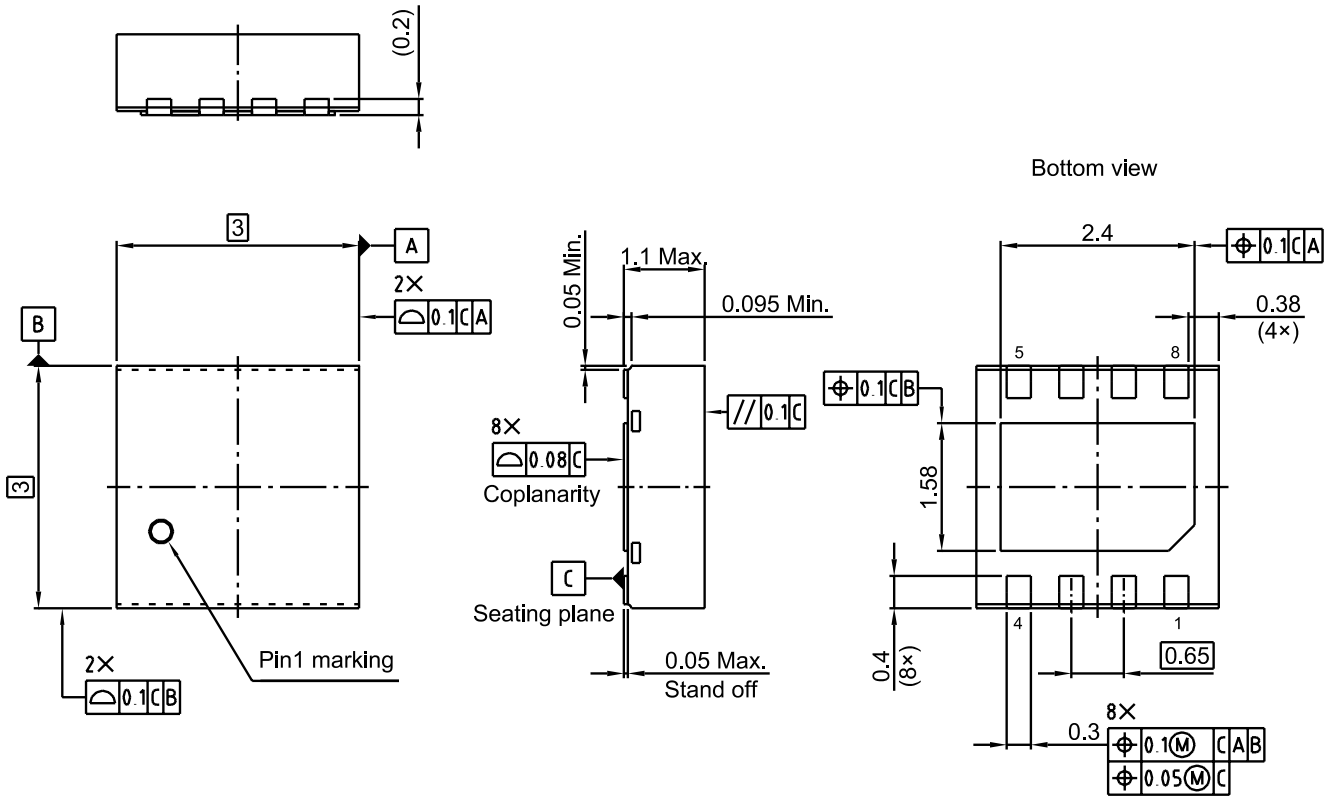

Figure 13 PG-TSON-8

Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations, the device is available as a Green Product. Green Products are RoHS compliant (Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

Information on packages

For more information on packages, such as recommendations on assembly, refer to www.infineon.com/packages.

Glossary

CAN

controller area network (CAN)

CDM

charged device model (CDM)

A model for characterizing the susceptibility of an electronic device to damage from electrostatic discharge (ESD).

EMC

electromagnetic compatibility (EMC)

The ability of electrical equipment and systems to function acceptably in their electromagnetic environment, by limiting the unintentional generation, propagation and reception of electromagnetic energy which may cause unwanted effects such as electromagnetic interference (EMI) or even physical damage in operational equipment.

EME

electromagnetic emission (EME)

An emission within the electromagnetic spectrum.

ESD

electrostatic discharge (ESD)

A sudden and momentary flow of electric current between two electrically charged objects caused by contact, an electrical short or dielectric breakdown.

GND

ground (GND)

HBM

human body model (HBM)

A model for characterizing the susceptibility of an electronic device to damage from electrostatic discharge (ESD) based on a human body.

I/O

input/output (I/O)

The communication between an information processing system and another information processing system.

IC

integrated circuit (IC)

A miniature electronic circuit built on the surface of a thin substrate of a semiconductor material.

PCB

printed circuit board (PCB)

A board that mechanically supports and electrically connects electronic components using conductive tracks, pads, and other features etched from copper sheets laminated onto a non-conductive substrate.

RoHS

Restriction of Hazardous Substances in Electrical and Electronic Equipment (RoHS)

European Union (EU) rules restricting the use of hazardous substances in electrical and electronic equipment to protect the environment and public health.

Revision history

Revision	Date	Changes
1.00	2025-12-18	Datasheet created

Trademarks

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